## Low Noise, Wideband, High IP3

# **Monolithic Amplifier Die**

## PMA2-153LN-D+

 $50\Omega$  0.5 to 15 GHz

## **The Big Deal**

- Ultra wideband, 0.5 to 15 GHz
- Flat gain over wideband, 16.7 dB with ±3.3 dB
- Low noise figure, 2.6 dB at 8 GHz
- High IP3, up to +28 dBm



## **Product Overview**

The PMA2-153LN-D+ is a PHEMT based wideband, low noise, flat gain MMIC amplifier die with a unique combination of low noise, high IP3, and flat gain over wideband making it ideal for sensitive, high-dynamic-range receiver applications. This design operates on a single 5V or 6V supply, is well matched for  $50\Omega$ .

**Key Features** 

Feature	Advantages	
Low noise • 2.2 dB at 2 GHz • 2.6 dB at 8 GHz	Enables lower system noise figure performance.	
High IP3 • +27.7 dBm at 2 GHz • +26.8 dBm at 8 GHz	Combination of low noise and high IP3 makes this MMIC amplifier die ideal for use in low noise receiver front end (RFE) as it gives the user advantages of sensitivity and two-tone IM performance at both ends of the dynamic range.	
Low operating voltage, 5V/6V.	Achieves high IP3 using low voltage.	
Wide bandwidth with flat gain • ±0.1 dB over 0.5 to 2 GHz • ±0.7 dB over 0.5 to 6 GHz • ±1.2 dB over 0.5 to 8 GHz • ±3.3 dB over 0.5 to 15 GHz	Enables usage in applications without external gain flattening networks.	
Unpackaged die	Enables users to integrate amplifier die directely into hybrids.	

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## $50\Omega$ 0.5 to 15 GHz

#### **Product Features**

- Low Noise figure, 2.6 dB at 8 GHz
- High IP3, up to +28 dBm
- Excellent Gain flatness, ±3.3 dB over 0.5 to 15 GHz at 6V

## **Typical Applications**

- WiFi
- WLAN
- UMTS
- LTE
- WiMAX
- S-band Radar
- C-band Satcom



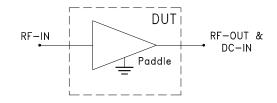
# +RoHS Compliant The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

Ordering Information: Refer to Last Page

### **General Description**

The PMA2-153LN-D+ is a PHEMT based wideband, low noise, flat gain MMIC amplifier die with a unique combination of low noise, high IP3, and flat gain over wideband making it ideal for sensitive, high-dynamic range receiver applications. This design operates on a single 5V or 6V supply, is well matched for  $50\Omega$ .

#### Simplified Schematic and Pad Description



Pad Function	Description (See Figure 2)
RF-IN	Connects to RF input via C1
RF-OUT & DC-IN	Connects to RF out and V <sub>DD</sub> via Bias-Tee
Ground	Connects to ground

Note: 1. Bond Pad material - Gold 2. Bottom of Die - Gold plated



### Electrical Specifications<sup>1</sup> at 25°C, unless noted

Parameter	Condition				V <sub>DD</sub> =5.0			Units
	(GHz)	Min.	Тур.	Max.	Min.	Тур.	Max.	
Frequency Range		0.5		15.0	0.5		15.0	GHz
Noise Figure	0.5		2.3			2.2		dB
	2.0		2.3			2.1		
	8.0		2.6			2.5		
	10.0		2.8			2.7		
	15.0		3.8			3.7		
Gain	0.5		19.0			18.1		dB
	2.0		18.9			18.0		
	8.0		16.8			16.0		
	10.0		16.0			15.3		
	15.0		12.5			11.7		
Input Return Loss	0.5		9.3			8.4		dB
	2.0		10.2			9.2		
	8.0		9.7			9.1		
	10.0		8.7			8.2		
	15.0		4.2			4.2		
Output Return Loss	0.5		13.5			11.7		dB
	2.0		13.0			11.6		
	8.0		22.9			21.0		
	10.0		17.4			17.1		
	15.0		6.9			6.2		
Output Power at 1dB Compression <sup>2</sup>	0.5		15.3			14.2		dBm
	2.0		15.2			14.0		
	8.0		14.8			13.2		
	10.0		14.8			13.2		
	15.0		11.2			10.5		
Output IP3	0.5		27.3			24.7		dBm
	2.0		27.7			24.9		
	8.0		26.8			24.4		
	10.0		26.7			24.7		
	15.0		24.0			21.9		
Device Operating Voltage (V <sub>DD</sub> )			6.0			5.0		V
Device Operating Current (I <sub>DD</sub> )		_	66	85	_	50	_	mA
Device Current Variation vs. Temperature <sup>3</sup>			-5.3			12.5		μΑ/°C
Device Current Variation vs. Voltage			0.0187			0.0187		mA/mV
Thermal Resistance, junction-to-ground lead			107			107		°C/W

Measured on Mini-Circuits Characterization Test Board. Die packaged in 2x2mm 8-lead MCLP package and soldered on MB-014-1. See Characterization Test Circuit (Fig. 1)
 Current increases at P1dB up to 10mA typ. at 5Volts V<sub>DD</sub>

#### Absolute Maximum Ratings<sup>4</sup>

Parameter	Ratings		
Operating Temperature (ground lead)	-40°C to 85°C		
Junction Temperature	160		
Total Power Dissipation	0.7W		
Input Power (CW), Vd=5,6V <sup>5</sup>	+20 dBm (0.7 - 7.75 GHz) 5 minutes max. +22 dBm (7.75 - 15 GHz) 5 minutes max. +8 dBm (continuous)		
DC Voltage	7V		

Permanent damage may occur if any of these limits are exceeded.

Electrical maximum ratings are not intended for continuous normal operation.

<sup>5.</sup> Measured on Mini-Circuits Characterization Test Board, MB-014-1



<sup>3. (</sup>Current at 85°C - Current at -45°C)/130

### **Characterization Test Circuit**

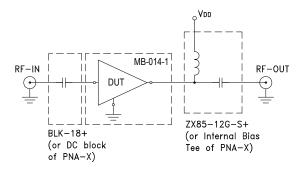


Fig 1. Characterization Circuit

Note: This block diagram is used for characterization. (DUT soldered on Mini-Circuits Characterization test board MB-014-1) Gain, Return loss, Output power at 1dB compression (P1 dB), output IP3 (OIP3) and noise figure measured using Agilent's N5242A PNA-X microwave network analyzer.

#### Conditions:

- 1. Gain and Return loss: Pin= -25dBm
- 2. Output IP3 (OIP3): Two tones, spaced 1 MHz apart, 0 dBm/tone at output.

## **Recommended Application Circuit**

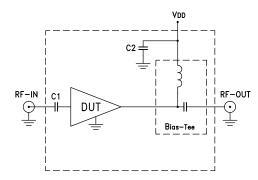
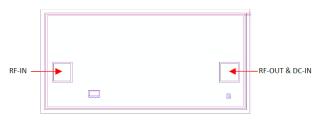


Fig 2. Application Circuit

Component	Size	Value
C1	0402	0.1μF
C2	0603	0.01μF

## **Die Layout**



Ground: bottom of die

Fig 3. Die Layout

### **Critical Dimensions**

Parameter	Values
Die Thickness, μm	100
Die Width, μm	410
Die Length, μm	830
Bond Pad Size	70 x 70

## Assembly and Handling Procedure

#### 1. Storage

Dice should be stored in a dry nitrogen purged desiccators or equivalent.

#### 2. ESD

MMIC PHEMPT amplifier dice are susceptible to electrostatic and mechanical damage. Die are supplied in antistatic protected mate rial, which should be opened in clean room conditions at an appropri ately grounded anti-static workstation. Devices need careful handling using correctly designed collets, vacuum pickup tips or sharp antistatic tweezers to deter ESD damage to dice.

#### 3. Die Attach

The die mounting surface must be clean and flat. Using conductive silver filled epoxy, recommended epoxies are DieMat DM6030HK-PT/H579 or Ablestik 84-1LMISR4. Apply sufficient epoxy to meet required epoxy bond line thickness, epoxy fillet height and epoxy coverage around total die periphery. Parts shall be cured in a nitrogen filled atmosphere per manufacturer's cure condition. It is recommended to use antistatic die pick up tools only.

#### 4. Wire Bonding

Bond pad openings in the surface passivation above the bond pads are provided to allow wire bonding to the dice gold bond pads. Thermosonic bonding is used with minimized ultrasonic content. Bond force, time, ultrasonic power and temperature are all critical parameters. Suggested wire is pure gold, 1 mil diameter. Bonds must be made from the bond pads on the die to the package or substrate. All bond wires should be kept as short as low as reasonable to minimize performance degradation due to undesirable series inductance.

## **Bonding Pad Position**

(Dimensions in µm, Typical)

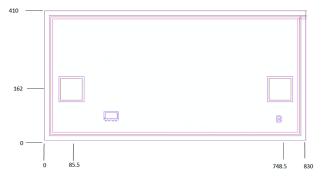
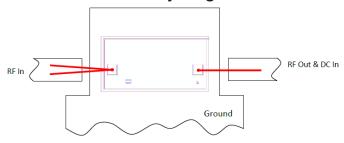


Fig 4. Bonding Pad Positions

## **Assembly Diagram**



Note: Ground bond wires are optional.

#### Recommended Wire Length, Typical

Wire	Wire Length (mm)	Wire Loop Height (mm)
RF-IN,	0.60	0.15
RF-OUT & DC-IN	1.00	0.30

Additional Detailed Techni additional information is available on or					
	Data Table	Data Table			
Performance Data	Swept Graphs	aphs			
	S-Parameter (S2P Files) Data Set wit	S-Parameter (S2P Files) Data Set with and without port extension(.zip file)			
Case Style	Die	Die			
Die Ordering and packaging information	Quantity, Package	Model No.			
	Small, Gel - Pak: 5,10,50,100 KGD* Medium <sup>†</sup> , Partial wafer: KGD*<2580 Large <sup>†</sup> , Full Wafer				
momaton	†Available upon request contact sales representative				
	Refer to <u>AN-60-067</u>				
<b>Environmental Ratings</b>	ENV-80				

<sup>\*</sup>Known Good Dice ("KGD") means that the dice in question have been subjected to Mini-Circuits DC test performance criteria and measurement instructions and that the parametric data of such dice fall within a predefined range. While DC testing is not definitive, it does help to provide a higher degree of confidence that dice are capable of meeting typical RF electrical parameters specified by Mini-Circuits.

### ESD Rating\*\*

Human Body Model (HBM): Class 1A (250 to <500V) in accordance with ANSI/ESD STM 5.1 - 2001

#### **Additional Notes**

- A. Performance and quality attributes and conditions not expressly stated in this specification document are intended to be excluded and do not form a part of this specification document.
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<sup>\*\*</sup> Tested in industry standard 2x2mm, 8-lead MCLP package.